

# S-parameter Data Library

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#### < Applicable condition >

The data in this library is obtained under the condition of 25°C, no DC bias, and small signal operation. Proper result might not be obtained if your condition is different from the above one.

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#### S-parameter is measured by using Network Analyzer.

- Test Board : Micro-strip line with 50 ohm characteristic impedance (FR4 0.4mm thick)
- Temperature : 25 degree Cel.



An example of test board for 2-port device

- DUT is put on a micro-strip line.
- TDK's recommended land pattern is formed around the DUT.
- Reference plane is set at the edge of the land pattern by calibration.
- So measurement data include the characteristics of land pattern.
- To satisfy passivity, measured S-parameter is corrected a little.

#### (Note)

S-parameters of a part of chip beads, inductors and multi-layer ceramic capacitors are converted from the impedance data measured by impedance analyzer. S-parameters of high frequency inductors are converted from the equivalent circuit model.

## Port Assignment (1/3)





(\*)Chip Beads, Inductors, Multilayer Ceramic Chip Capacitors, Chip Varistors

## Port Assignment (2/3)



Common mode filter (CMF)	
CMF array	
Multi-line CMF	

## Port Assignment (3/3)





## Example



This example is of a filter composed of one inductor and one capacitor. If these elements are ideal, it is a simple low pass filter with cut-off frequency about 50MHz (green line). But the actual behavior is different. There are two poles in the attenuation band (blue line).

By using the TDK S-parameter Data Library, the two poles can be realized (red line).





• Near end crosstalk (NEXT) of differential mode |Sdd31| is -55dB, and far end crosstalk (FEXT) |Sdd41| is -73dB at 100MHz.





S-parameter consists of a finite frequency range. So, please do NOT use it beyond the range.

#### $Ex.|S_{^{21}}| \ of \ a \ Inductor$



Extrapolating to 20GHz using Measurement Data to 3GHz by a Simulator

### Note



•There is no difference in S-parameter by the tolerance because TDK S-parameter Data Library uses typical data of the product.

